



R&S® RTP-K136/137 8/16 GBPS ADVANCED EYE ANALYSIS

Get your results faster.

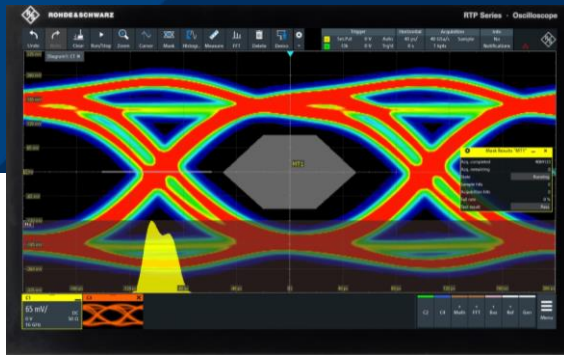
The perfect choice for

High speed interface characterization

System design debugging

Eye diagram measurements

Mask and histogram testing



- ▶ The advanced eye analysis option allows users to generate eye diagrams quickly and offers comprehensive tools for in-depth analysis
- ▶ For serial data interfaces with embedded clock signals, it features user-configurable clock data recovery that is built into the R&S® RTP oscilloscope trigger hardware

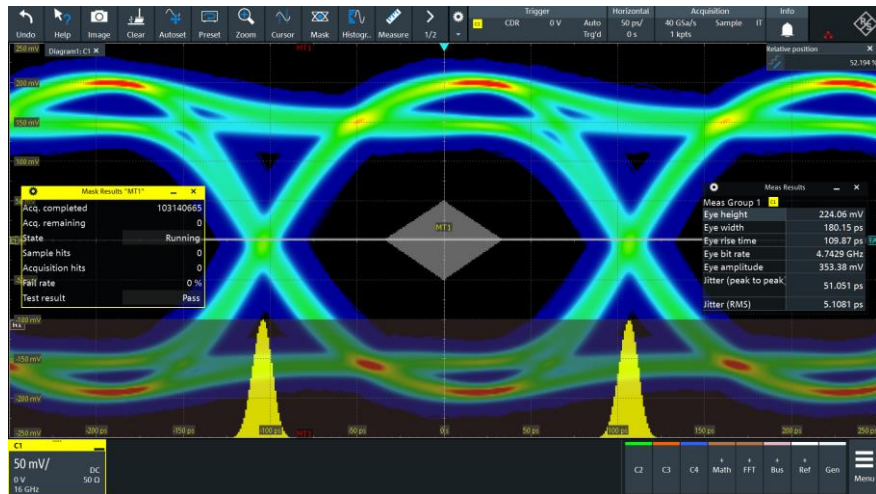
Key specifications	Hardware clock data recovery (HW-CDR)
Nominal bit rate	21 kbps to 8/16 Gbps
Bandwidth	1/500 to 1/3000 of the nominal bit rate
Source	Analog channels, differential channels
Display	Display recovered clock as a math signal
Others	Combinable with real-time deembedding

Your benefit	Features
Continuously running clock data recovery as part of trigger hardware	<ul style="list-style-type: none"> ▶ User-configurable nominal bit rate and tracking bandwidth ▶ Selectable serial standards for configuration ▶ Automated bit rate estimation
Live eye diagram for long-term monitoring and detection of rare faults and interferers	<ul style="list-style-type: none"> ▶ > 400 000 unit intervals/s ▶ Continuously trigger and display overlay of individual bits ▶ Apply hardware accelerated masks and histograms
From quick insights to in-depth results	<ul style="list-style-type: none"> ▶ Three steps to an eye diagram (select source, select serial standard, set state to "ON") ▶ Use gates, qualifying signals and bit pattern filters to focus analysis ▶ Eye stripe function to navigate between mask test violations and coupled zoom to investigate details ▶ Choose from 18 automated eye measurements ▶ Select a mask from a standard mask library



Scan or click for more information

Live eye diagram – fast, continuous acquisition and overlay of single bits



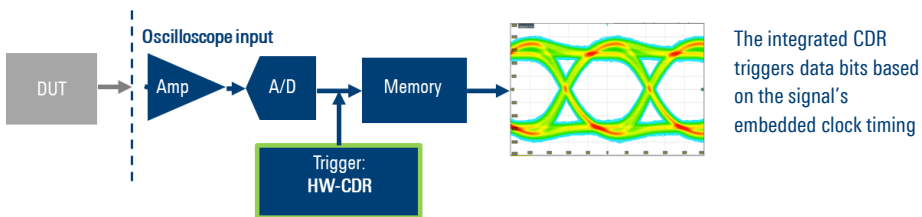
Test configuration for 5 Gbps data signal: CDR trigger; 50 ps/div horizontal scaling to acquire one bit at a time.



Fastest signal integrity debugging

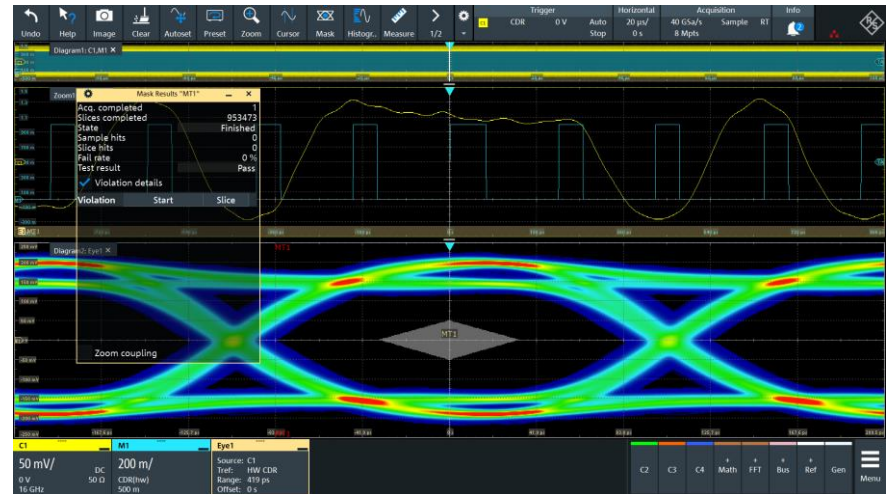
- ▶ Fast glance on jitter and noise due to > 400 000 unit intervals/s
- ▶ Detects rare interferers, e.g. crosstalk between adjacent components
- ▶ Allows long-term monitoring over hours and days
- ▶ Use masks and histograms

HW-CDR as part of the R&S®RTP oscilloscope trigger system



The integrated CDR triggers data bits based on the signal's embedded clock timing

Advanced eye diagram – acquisition of bit stream and overlay of HW-CDR sliced bits



Test configuration for a 5 Gbps data signal: CDR trigger; 20 μs/div horizontal scaling to acquire 1 million sequential bits.



In-depth signal integrity characterization

- ▶ Analyze the data eye based on the bitstream length defined in interface standards, e.g. USB 3.2 Gen1: 1 mil. UIs
- ▶ Characterization of transmitter output (TX) and signal path, e.g. data dependent jitter and noise
- ▶ Display and perform further analysis on HW-CDR signal (math signal)
- ▶ Advanced configuration of eye diagram (display, gate, bit pattern, etc.)
- ▶ Eye stripe function to navigate between mask test violations in the coupled zoom
- ▶ Apply automated eye measurements

Ordering details

Description	Item
16 GHz high-performance oscilloscope	R&S®RTP164B
8 Gbps advanced eye analysis option	R&S®RTP-K136
16 Gbps advanced eye analysis option	R&S®RTP-K137

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